

Docket No.: 1639.1001D

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Takatoshi KOBAYASHI, et al.

Serial No. 10/621,547

Group Art Unit: 2822

Confirmation No. 1327

Filed: July 18, 2003

Examiner: Ida M. Soward

For: POWER SEMICONDUCTOR MODULE

COMMENTS REGARDING STATEMENT OF REASONS FOR ALLOWANCE

Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

Sir:

A Statement of Reasons for Allowance was forwarded in the Office Action mailed September 21, 2004.

MPEP §1302.14 states, in part:

Where specific reasons are recorded by the examiner, care must be taken to ensure that statements of reasons for allowance (or indication of allowable subject matter) are accurate, precise and do not place unwarranted interpretations, whether broad or narrow upon the claims. The examiner should keep in mind the possible misinterpretations of his or her statement that may be made and its possible estoppel effects.

The Examiner refers to claim 3. However, instead of quoting claim 3 in its entirety, the Examiner refers to a portion of the claim. The Examiner refers to these features "in particlar." It is submitted that the use of the term "in particular" and the recitation of only a portion of the claim is improper in that it provides certain emphasis which might "place unwarranted interpretations, whether broad or narrow, upon the claims." (M.P.E.P. §1302.14).

It is further submitted that the claims speak for themselves and should not be interpreted based on the Examiner's characterizations of same. It is also submitted that the claims provide their own best evidence as to the reasons for allowance.

In summary, it is submitted that the Examiner's Statement "raises possible misinterpretations... and possible estoppel effects" (M.P.E.P. §1302.14) and is therefore improper.

Respectfully submitted,

STAAS & HALSEY LLP

Date: 6-2-05

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